

November 2009

UniFET™

FDT3N40

400V N-Channel MOSFET

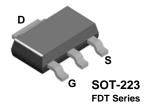
Features

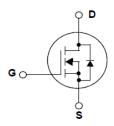
- 2A, 400V, $R_{DS(on)} = 3.4\Omega @V_{GS} = 10 \text{ V}$
- Low gate charge (typical 4.5 nC)
- Low C_{rss} (typical 3.7 pF)
- Fast switching
- 100% avalanche tested
- Improved dv/dt capability

Description

These N-Channel enhancement mode power field effect transistors are produced using Fairchild's proprietary, planar stripe, DMOS technology.

This advanced technology has been especially tailored to minimize on-state resistance, provide superior switching performance, and withstand high energy pulse in the avalanche and commutation mode. These devices are well suited for high efficient switched mode power supplies and active power factor correction.





Absolute Maximum Ratings

Symbol	Parameter			FDT3N40	Unit
V _{DSS}	Drain-Source Voltage			400	V
I _D	Drain Current	- Continuous (T _C = 25° continuous (T _C = 100		2.0 * 1.2 *	A A
I _{DM}	Drain Current	- Pulsed	(Note 1)	8.0 *	А
V _{GSS}	Gate-Source voltage			±30	V
E _{AS}	Single Pulsed Avalanche Energy		(Note 2)	46	mJ
I _{AR}	Avalanche Current		(Note 1)	2	A
E _{AR}	Repetitive Avalanche	Energy	(Note 1)	0.2	mJ
dv/dt	Peak Diode Recover	y dv/dt	(Note 3)	4.5	V/ns
P _D	Power Dissipation (T _C = 25°C) - Derate above 25°C			2 0.02	W W/°C
T _{J,} T _{STG}	Operating and Storage Temperature Range			-55 to +150	°C
T _L	Maximum Lead Temperature for Soldering Purpose, 1/8" from Case for 5 Seconds		pose,	300	°C

^{*} Drain current limited by maximum junction temperature

Thermal Characteristics

Symbol	Parameter	Тур	Max	Unit
$R_{\theta JA}^{*}$	Thermal Resistance, Case-to-Sink Typ.	-	60	°C/W

^{*} Surface Mounted on JESD51-3 Board, T<0.1sec.

Package Marking and Ordering Information

Device Marking	Device	Package	Reel Size	Tape Width	Quantity
FDT3N40	FDT3N40TF	SOT-223	330mm 12mm		4000

Electrical Characteristics $T_C = 25$ °C unless otherwise noted

Symbol	Parameter	Conditions	Min.	Тур.	Max	Units
Off Charac	teristics					
BV _{DSS}	Drain-Source Breakdown Voltage $V_{GS} = 0V, I_D = 250\mu A$		400			V
ΔBV _{DSS} / ΔT _J	Breakdown Voltage Temperature Coefficient	I _D = 250μA, Referenced to 25°C		0.4		V/°C
I _{DSS}	Zero Gate Voltage Drain Current	$V_{DS} = 400V, V_{GS} = 0V$ $V_{DS} = 320V, T_C = 125^{\circ}C$			1 10	μA μA
I _{GSSF}	Gate-Body Leakage Current, Forward	$V_{GS} = 30V, V_{DS} = 0V$			100	nA
I _{GSSR}	Gate-Body Leakage Current, Reverse	$V_{GS} = -30V$, $V_{DS} = 0V$			-100	nA
On Charac	teristics					
V _{GS(th)}	Gate Threshold Voltage	$V_{DS} = V_{GS}, I_{D} = 250 \mu A$	3.0		5.0	V
R _{DS(on)}	Static Drain-Source On-Resistance	V _{GS} = 10V, I _D = 1A		2.8	3.4	Ω
9 _{FS}	Forward Transconductance	$V_{DS} = 40V, I_D = 1A$ (Note 4)		2		S
Dynamic C	haracteristics					
C _{iss}	Input Capacitance	$V_{DS} = 25V, V_{GS} = 0V,$		173	225	pF
C _{oss}	Output Capacitance	f = 1.0MHz		30	40	pF
C _{rss}	Reverse Transfer Capacitance		1	3.7	6	pF
Switching	Characteristics					
t _{d(on)}	Turn-On Delay Time	$V_{DD} = 200V, I_{D} = 2A$		10	30	ns
t _r	Turn-On Rise Time	$R_G = 25\Omega$		30	70	ns
t _{d(off)}	Turn-Off Delay Time			10	30	ns
t _f	Turn-Off Fall Time	(Note 4, 5)		25	60	ns
Q_g	Total Gate Charge	V _{DS} = 320V, I _D = 2A		4.5	6	nC
Q _{gs}	Gate-Source Charge	V _{GS} = 10V		1.2		nC
Q_{gd}	Gate-Drain Charge	(Note 4, 5)		2		nC
Drain-Sour	ce Diode Characteristics and Maximum	n Ratings		·		'
I _S	Maximum Continuous Drain-Source Dio	de Forward Current			2	Α
I _{SM}	Maximum Pulsed Drain-Source Diode Forward Current				8	Α
V_{SD}	Drain-Source Diode Forward Voltage	$V_{GS} = 0V$, $I_S = 2A$	1		1.4	V
t _{rr}	Reverse Recovery Time	$V_{GS} = 0V$, $I_S = 2A$		210		ns
Q _{rr}	Reverse Recovery Charge	$dI_F/dt = 100A/\mu s $ (Note 4)		0.75		μС

NOTES

^{1.} Repetitive Rating: Pulse width limited by maximum junction temperature

^{2.} L = 10mH, I_{AS} = 2A, V_{DD} = 50V, R_{G} = 25 Ω , Starting T_{J} = 25 $^{\circ}C$

^{3.} I $_{SD} \leq$ 2A, di/dt \leq 200A/ $\mu s,~V_{DD} \leq$ BV $_{DSS},~Starting~T_{J}$ = 25°C

^{4.} Pulse Test: Pulse width $\leq 300 \mu \text{s}, \ \text{Duty Cycle} \leq 2\%$

^{5.} Essentially Independent of Operating Temperature Typical Characteristics

Typical Performance Characteristics

Figure 1. On-Region Characteristics

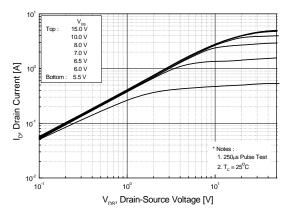


Figure 3. On-Resistance Variation vs. Drain Current and Gate Voltage

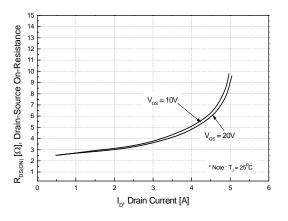


Figure 5. Capacitance Characteristics

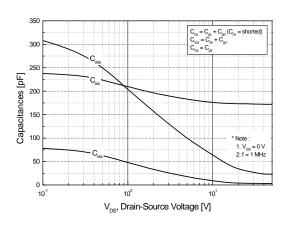


Figure 2. Transfer Characteristics

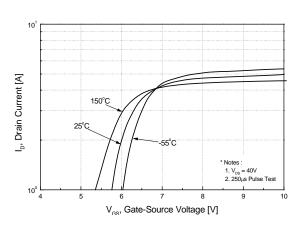


Figure 4. Body Diode Forward Voltage Variation vs. Source Current and Temperatue

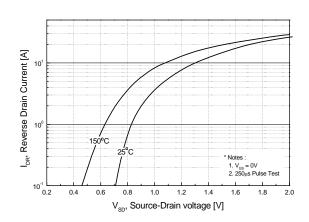
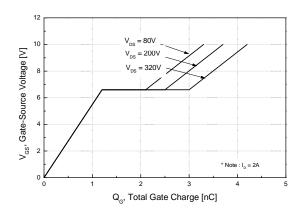


Figure 6. Gate Charge Characteristics



Typical Performance Characteristics (Continued)

Figure 7. Breakdown Voltage Variation vs. Temperature

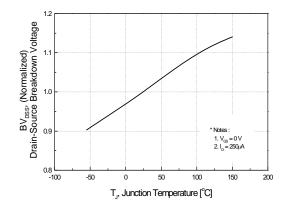


Figure 8. On-Resistance Variation vs. Temperature

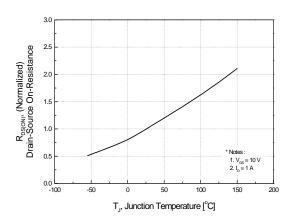
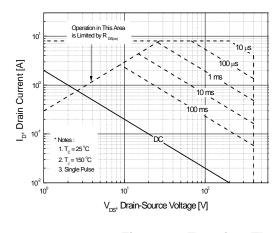


Figure 9. Maximum Safe Operating Area

Figure 10. Maximum Drain Current vs. Case Temperature



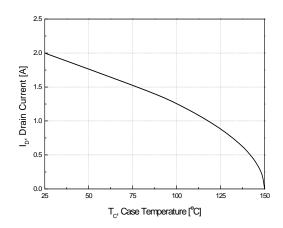
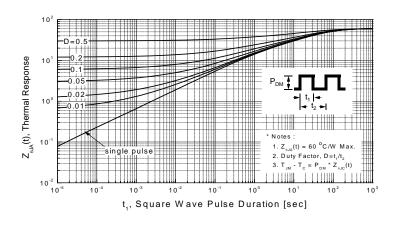
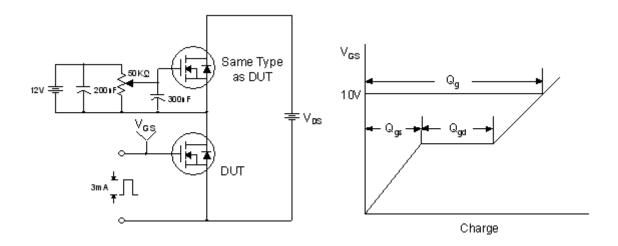


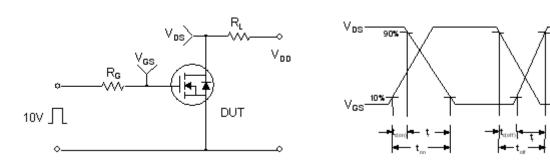
Figure 11. Transient Thermal Response Curve



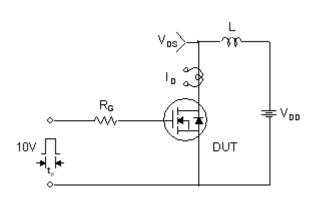
Gate Charge Test Circuit & Waveform

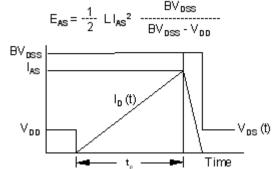


Resistive Switching Test Circuit & Waveforms

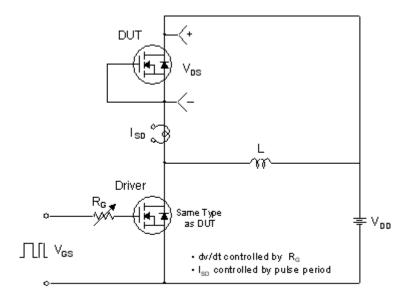


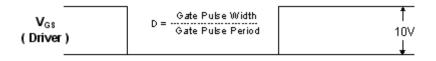
Unclamped Inductive Switching Test Circuit & Waveforms

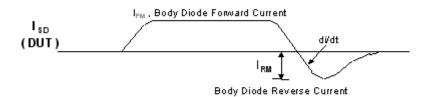


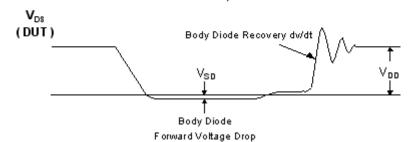


Peak Diode Recovery dv/dt Test Circuit & Waveforms



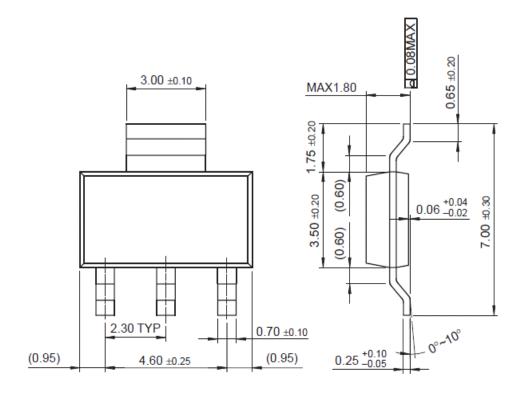


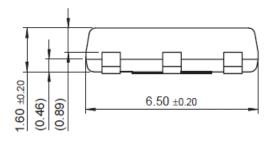




Mechanical Dimensions

SOT-223









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